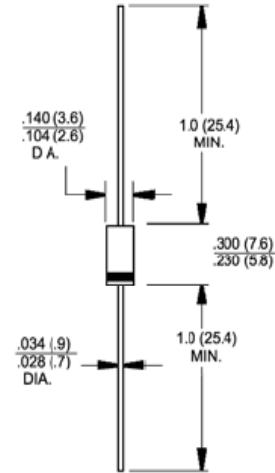
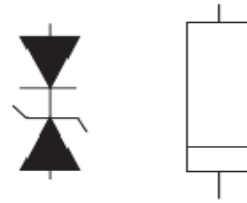


### Features

- Metal-Semiconductor junction with guard ring
- Plastic package has Underwriters Laboratory Flammability Classification 94V-0
- Protection of the Mosfet in flyback power supply
- TRANSIL™ and blocking diode in a single package



Dimensions in inches and (millimeters)  
D0-15

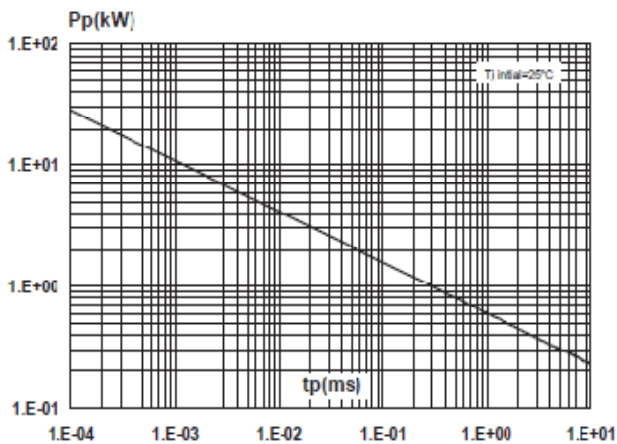
ABSOLUTE MAXIMUM RATINGS							
PARAMETER	SYMBOL	Value	Value			UNIT	
Storage temperature	T <sub>stg</sub>	-55~+150				°C	
Junction temperature	T <sub>j</sub>	150				°C	
Maximum power dissipation T <sub>lead</sub> =90°C	P	1.5				W	
ELECTRICAL CHARACTERISTICS TRANSIL(T <sub>j</sub> = 25 °C unless otherwise noted)							
PARAMETER	SYMBOL	Test conditions	Value			UNIT	
			Min.	Typ.	Max.		
Maximum peak pulse current at TP=10/1000uS	P <sub>PK</sub>	I <sub>pp</sub> =2.7A	—	—	219	V	
Leakage current	T <sub>j</sub> =25°C	IR	VR=136V	—	—	1	uA
	T <sub>j</sub> =125			—	—	10	
Breakdown voltage	VBR	IR=1mA	150	160	170	V	
Temperature coefficient	αT	—	—	—	10.8	10 <sup>-4</sup> /°C	
ELECTRICAL CHARACTERISTICS DIODE(T <sub>j</sub> = 25 °C unless otherwise noted)							
PARAMETER	SYMBOL	Test conditions	Value			UNIT	
			Min.	Typ.	Max.		
Reverse leakage current	T <sub>j</sub> =25°C	IR	VR=VRRM	—	—	3	uA
	T <sub>j</sub> =125			—	3	20	
Repetitive peak reverse voltage	VRRM	T <sub>j</sub> =25°C	700	—	—	V	
Reverse recovery time	TRR	IF=0.5A,IR=1.0A,IRR=0.25A	—	—	50	nS	
Peak forward voltage	T <sub>j</sub> =25°C	VFP	IF=1A DI <sub>F</sub> /dt=100A/uS	—	—	12	V
	T <sub>j</sub> =125			—	—	18	

CAPACITANCE			
PARAMETER	SYMBOL	Typical value	UNIT
Total parasitic capacitance 1MHZ 4.0V	C <sub>j</sub>	35	pF
THERMAL RESISTANCES			
PARAMETER	SYMBOL	Typical value	UNIT
Junciton to leads L=10mm	R <sub>θjL</sub>	40	°C/W
Junciton to ambient condition see note 1	R <sub>θJa</sub>	105	°C/W

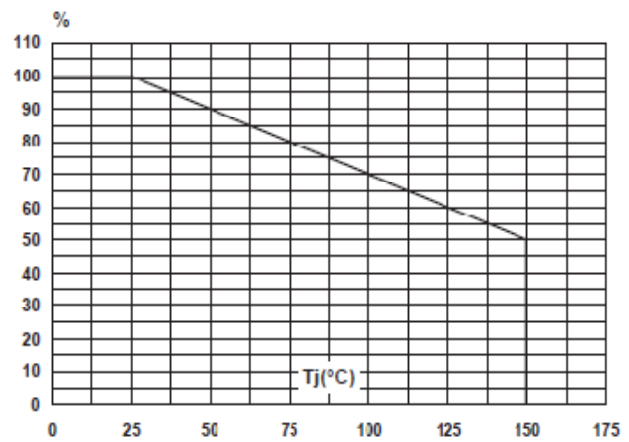
Notes: 1. Thermal Resistance From Junction to Ambient and From Junction to Lead Mounted on P.C.B with 0.2"×0.2"(5.0×5.0mm) Copper Pad Areas

### RATINGS AND CHARACTERISTICS CURVES

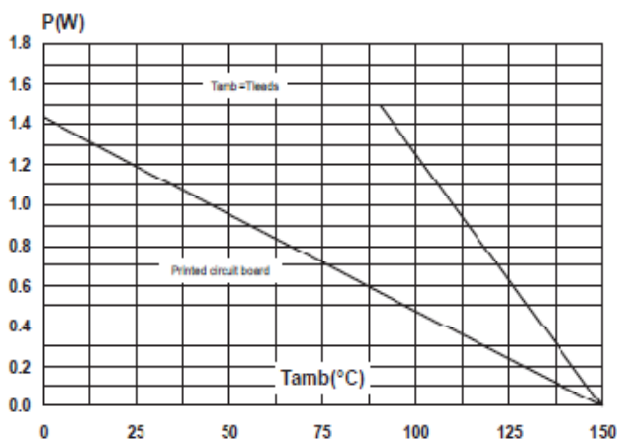
**Fig. 1:** Peak pulse power versus exponential pulse duration.



**Fig. 2:** Relative variation of peak pulse power versus initial junction temperature.



**Fig. 3:** Average power dissipation versus ambient temperature.



**Fig. 4:** Variation of thermal impedance junction to ambient versus pulse duration (printed circuit board epoxy FR4)

